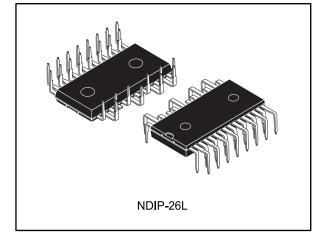
STIPN1M50-H



SLLIMM[™]-nano small low-loss intelligent molded module IPM, 3-phase inverter, 1 A, 3.6 Ω max., 500 V MOSFET

Datasheet - production data



Features

- IPM 1 A, 500 V, R_{DS(on)}= 3.6 Ω, 3-phase MOSFET inverter bridge including control ICs for gate driving
- Optimized for low electromagnetic interference
- 3.3 V, 5 V, 15 V CMOS/TTL input comparators with hysteresis and pulldown/pull-up resistors
- Undervoltage lockout
- Internal bootstrap diode
- Interlocking function
- Smart shutdown function
- Comparator for fault protection against overtemperature and overcurrent
- Op-amp for advanced current sensing
- Optimized pinout for easy board layout
- Up to ±2 kV ESD protection (HBM C = 100 pF, R = 1.5 kΩ)

Applications

- 3-phase inverters for small power motor drives
- Dish washers, refrigerator compressors, heating systems, air-conditioning fans, draining and recirculation pumps

Description

This SLLIMM (small low-loss intelligent molded module) nano provides a compact, high performance AC motor drive in a simple, rugged design. It is composed of six MOSFETs and three half-bridge HVICs for gate driving, providing low electromagnetic interference (EMI) characteristics with optimized switching speed. The package is optimized for thermal performance and compactness in built-in motor applications, or other low power applications where assembly space is limited. This IPM includes an operational amplifier, completely uncommitted, and a comparator that can be used to design a fast and efficient protection circuit. SLLIMM[™] is a trademark of STMicroelectronics.

Table 1: Device summary

Order code	Marking	Package	Packing
STIPN1M50-H	IPN1M50-H	NDIP-26L	Tube

June 2017

DocID030075 Rev 3

1/22

This is information on a product in full production.

Contents

Cor	ntents		
1	Internal	schematic diagram and pin configuration	3
2	Electric	al ratings	6
	2.1	Absolute maximum ratings	6
	2.2	Thermal data	6
3	Electric	al characteristics	7
	3.1	Inverter part	7
	3.2	Control part	9
	3.3	Waveform definitions	12
4	Smart s	hutdown function	13
5	Applica	tion circuit example	15
	5.1	Guidelines	16
6	Package	e information	17
	6.1	NDIP-26L package information	18
	6.2	NDIP-26L packing information	20
7	Revisio	n history	21



1

Internal schematic diagram and pin configuration

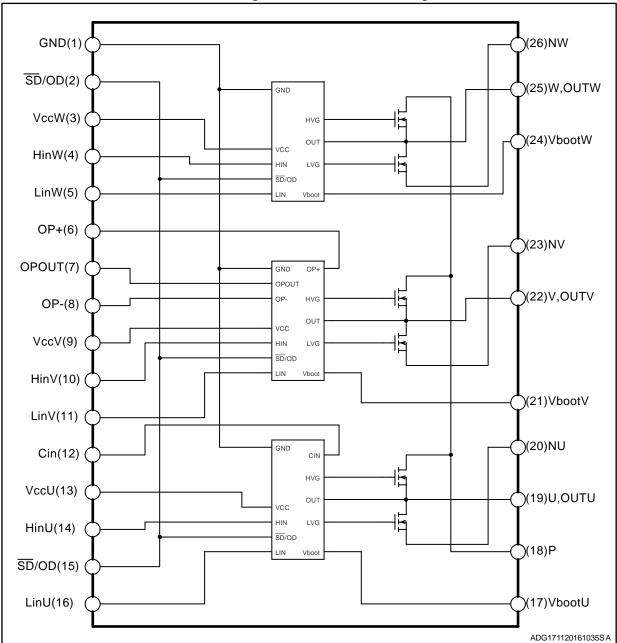


Figure 1: Internal schematic diagram



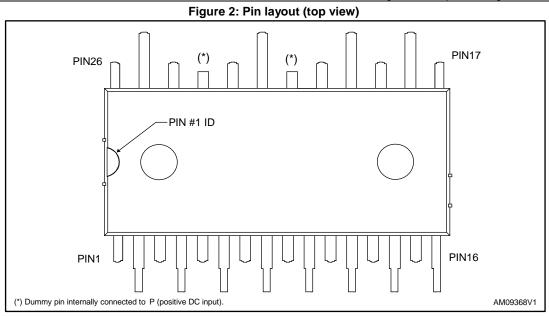
Internal schematic diagram and pin configuration

STIPN1M50-H

·	Table 2: Pin description				
Pin	Symbol	Description			
1	GND	Ground			
2	<u>SD</u> /OD	Shutdown logic input (active low) / open-drain (comparator output)			
3	Vcc W	Low voltage power supply W phase			
4	HIN W	High-side logic input for W phase			
5	LIN W	Low-side logic input for W phase			
6	OP+	Op-amp non inverting input			
7	OPout	Op-amp output			
8	OP-	Op-amp inverting input			
9	Vcc V	Low voltage power supply V phase			
10	HIN V	High-side logic input for V phase			
11	LIN V	Low-side logic input for V phase			
12	CIN	Comparator input			
13	Vcc U	Low voltage power supply for U phase			
14	HIN U	High-side logic input for U phase			
15	<u>SD</u> /OD	Shutdown logic input (active low) / open-drain (comparator output)			
16	LIN U	Low-side logic input for U phase			
17	V _{BOOT} U	Bootstrap voltage for U phase			
18	Р	Positive DC input			
19	U, OUTu	U phase output			
20	Nu	Negative DC input for U phase			
21	V _{BOOT} V	Bootstrap voltage for V phase			
22	V, OUT_V	V phase output			
23	Nv	Negative DC input for V phase			
24	VBOOT W	Bootstrap voltage for W phase			
25	W,OUT_W	W phase output			
26	Nw	Negative DC input for W phase			



Internal schematic diagram and pin configuration





2 Electrical ratings

2.1 Absolute maximum ratings

	Table 3: Inverter part					
Symbol	Parameter	Value	Unit			
V _{DSS}	MOSFET blocking voltage (or drain-source voltage) for each MOSFET ($V_{IN}^{(1)}=0$)	500	V			
± lo	Continuous current each MOSFET	1	А			
± I _{DP} ⁽²⁾	Peak drain current each MOSFET (less than 1 ms)	2	А			
Ρτοτ	Each MOSFET total dissipation at T_C = 25 °C	9.6	W			

Notes:

 $^{(1)}\mbox{Applied}$ among HINi, LINi and GND for i = U, V, W.

 $\ensuremath{^{(2)}}\ensuremath{\mathsf{Pulse}}$ width limited by max. junction temperature.

Symbol	Parameter	Min.	Max.	Unit
Vout	Output voltage applied among OUT_U , OUT_V , OUT_W - GND	V _{boot} - 21	V _{boot} + 0.3	V
Vcc	Low voltage power supply	- 0.3	21	V
Vcin	Comparator input voltage	- 0.3	Vcc + 0.3	V
V _{op+}	Op-amp non-inverting input	- 0.3	Vcc + 0.3	V
V _{op-}	Op-amp inverting input	- 0.3	V _{CC} + 0.3	V
V _{boot}	Bootstrap voltage	- 0.3	620	V
Vin	Logic input voltage applied among HIN, LIN and GND	- 0.3	15	V
$V_{\overline{SD}/OD}$	Open-drain voltage	- 0.3	15	V
$\Delta V_{\text{OUT/dT}}$	Allowed output slew rate		50	V/ns

Table 4: Control part

Table 5: Total system

Symbol	Parameter	Value	Unit
Viso	Isolation withstand voltage applied between each pin and heatsink plate (AC voltage, t = 60 s)		V
Tj	Power chip operating junction temperature range	-40 to 150	°C
Tc	Module case operation temperature range	-40 to 125	°C

2.2 Thermal data

Table 6: Thermal data

Symbol	Parameter	Value	Unit
R _{th(j-c)}	Thermal resistance junction-case	13	°C/W



3 Electrical characteristics

 $T_J = 25$ °C unless otherwise specified.

3.1 Inverter part

	Table 7: Static					
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
IDSS	Zero-gate voltage drain current	V _{DS} = 500 V, V _{CC} = 15 V; V _{Boot} = 15 V			1	mA
V _{(BR)DSS}	Drain-source breakdown voltage	$\label{eq:Vcc} \begin{split} V_{\text{CC}} &= V_{\text{boot}} = 15 \text{ V}, \ V_{\text{IN}}{}^{(1)} = 0 \text{ V}, \\ I_{\text{D}} &= 1 \text{ mA} \end{split}$	500			V
R _{DS(on)}	Static drain source turn-on resistance	$V_{CC} = V_{boot} = 15 V,$ $V_{IN}^{(1)} = 0 - 5 V, I_D = 0.5 A$		3.2	3.6	Ω
V _{SD}	Drain-source diode forward voltage	$V_{IN}^{(1)} = 0$ "logic state", $I_D = 1 \text{ A}$		0.9	1.6	V

Notes:

 $^{(1)}\mbox{Applied}$ among HINx, LINx and GND for x=U,V,W.

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
ton ⁽¹⁾	Turn-on time		-	226	-	
t _{c(on)} ⁽¹⁾	Crossover time (on)	V _{DD} = 300 V,	-	130	-	
t _{off} ⁽¹⁾	Turn-off time	$V_{CC} = V_{boot} = 15 V,$	-	248	-	ns
t _{c(off)} ⁽¹⁾	Crossover time (off)	$V_{IN}^{(2)} = 0 - 5 V,$ Ic = 0.5 A	-	56	-	
trr	Reverse recovery time	(see Figure 4: "Switching time	-	155	-	
Eon	Turn-on switching energy	definition")	-	25	-	1
Eoff	Turn-off switching energy		-	3.8	-	μJ

Table 8: Inductive load switching time and energy

Notes:

 $^{(1)}t_{\text{ON}}$ and t_{OFF} include the propagation delay time of the internal drive. $t_{\text{C(ON)}}$ and $t_{\text{C(OFF)}}$ are the switching time of MOSFET itself under the internally given gate driving conditions.

 $^{(2)}\mbox{Applied}$ among HINx, LINx and GND for x=U,V,W.



Electrical characteristics

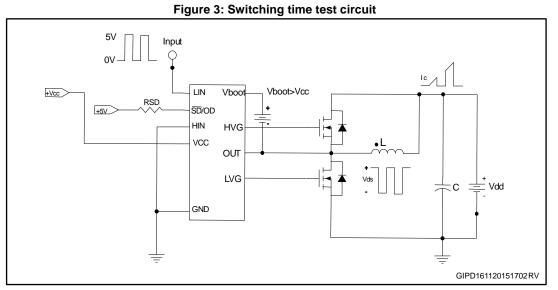
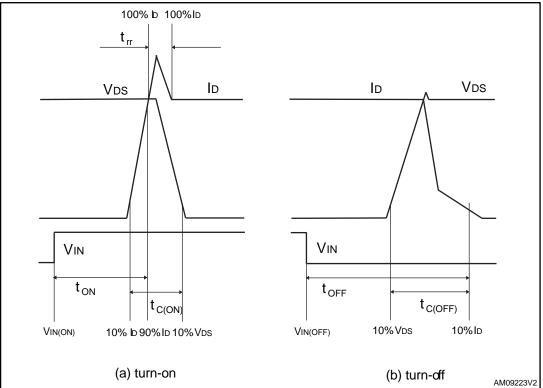
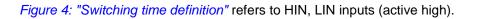


Figure 4: Switching time definition





3.2 Control part

	Table 9: Low voltage power supply (vcc = 15 v unless otherwise specified)						
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit	
Vcc_hys	Vcc UV hysteresis		1.2	1.5	1.8	V	
V _{CC_thON}	V _{CC} UV turn ON threshold		11.5	12	12.5	V	
Vcc_thOFF	Vcc UV turn OFF threshold		10	10.5	11	V	
I _{qccu}	Undervoltage quiescent supply current	$\label{eq:Vcc} \begin{array}{l} V_{CC} = 10 \ V, \ \overline{\text{SD}}/\text{OD} = 5 \ V; \\ \text{LIN} = 0 \ V; \ \text{H}_{\text{IN}} = 0, \\ \text{C}_{\text{IN}} = 0 \ V \end{array}$			150	μA	
Iqcc	Quiescent current	$\label{eq:Vcc} \begin{array}{l} V_{cc} = 15 \ V, \ \overline{\text{SD}}/\text{OD} = 5 \ V; \\ \text{LIN} = 0 \ V; \ \text{H}_{\text{IN}} = 0, \\ \text{C}_{\text{IN}} = 0 \ V \end{array}$			1	mA	
V _{ref}	Internal comparator (CIN) reference voltage		0.5	0.54	0.58	V	

Table 9: Low voltage power supply (Vcc = 15 V unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V_{BS_hys}	V _{BS} UV hysteresis		1.2	1.5	1.8	V
V_{BS_thON}	V _{BS} UV turn-ON threshold		11.1	11.5	12.1	V
$V_{\text{BS_thOFF}}$	VBS UV turn-OFF threshold		9.8	10	10.6	V
I _{QBSU}	Undervoltage V _{BS} quiescent current	$\label{eq:BB} \begin{array}{l} V_{BS} < 9 \ V, \ \overline{\text{SD}} / \text{OD} = 5 \ V; \\ \text{LIN} = 0 \ V \ \text{and} \ \text{HIN} = 5 \ V; \\ \text{C}_{\text{IN}} = 0 \ V \end{array}$		70	110	μA
IQBS	V _{BS} quiescent current	$\label{eq:VBS} \begin{array}{l} V_{BS} = 15 \text{ V}, \ \overline{\text{SD}}/\text{OD} = 5 \text{ V}; \\ \text{LIN} = 0 \text{ V} \text{ and } \text{HIN} = 5 \text{ V}; \\ \text{C}_{\text{IN}} = 0 \text{ V} \end{array}$		200	300	μA
R _{DS(on)}	Bootstrap driver on- resistance	LVG ON		120		Ω



Electrical characteristics

STIPN1M50-H

characteris							
	Table 11: Logic inputs (Vcc = 15 V unless otherwise specified)						
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit	
Vil	Low logic level voltage				0.8	V	
Vih	High logic level voltage		2.25			V	
IHINh	HIN logic "1" input bias current	HIN = 15 V	20	40	100	μA	
Ihini	HIN logic "0" input bias current	HIN = 0 V			1	μA	
ILINh	LIN logic "1" input bias current	LIN = 15 V	20	40	100	μA	
I _{LINI}	LIN logic "0" input bias current	LIN = 0 V			1	μA	
IsDh	SD logic "0" input bias	<u>SD</u> = 15 V	30	120	300	μΑ	
I _{SDI}	SD logic "1" input bias current	$\overline{\text{SD}} = 0 \text{ V}$			3	μA	
Dt	Dead time	see Figure 5: "Dead time and interlocking waveform definitions"		180		ns	

Table 12: Op-amp characteristics (Vcc = 15 V unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Vio	Input offset voltage	$V_{ic} = 0 V, V_o = 7.5 V$			6	mV
l _{io}	Input offset current			4	40	nA
l _{ib}	Input bias current (1)	$V_{ic} = 0 V, V_o = 7.5 V$		100	200	nA
Vol	Low level output voltage	R_L = 10 k Ω to V_{CC}		75	150	mV
Vон	High level output voltage	R_{L} = 10 k Ω to GND	14	14.7		V
lo	Output short-circuit current	Source, $V_{id} = +1 V$; $V_o = 0 V$	16	30		mA
		Sink, V_{id} = -1 V; V_o = V _{CC}	50	80		mA
SR	Slew rate	$V_i = 1 - 4 V; C_L = 100 pF;$ unity gain	2.5	3.8		V/µs
GBWP	Gain bandwidth product	V _o = 7.5 V	8	12		MHz
A _{vd}	Large signal voltage gain	R _L = 2 kΩ	70	85		dB
SVR	Supply voltage rejection ratio	vs. Vcc	60	75		dB
CMRR	Common mode rejection ratio		55	70		dB

Notes:

 $^{(1)}\mbox{The}$ direction of input current is out of the IC.



STIPN1M50-H

Electrical characteristics

Tab	Table 13: Sense comparator characteristics (V _{CC} = 15 V unless otherwise specified)						
Symbol	Parameter Test conditions Min.		Тур.	Max.	Unit		
l _{ib}	Input bias current	Vcin = 1 V			3	μA	
V_{od}	Open-drain low level output voltage	l _{od} = 3 mA			0.5	V	
Ron_od	Open-drain low level output resistanceIod = 3 mA166			Ω			
RPD_SD	SD pull-down resistor (1)			125		kΩ	
t _{d_comp}	Comparator delay	$\overline{\text{SD}}$ /OD pulled to 5 V through 100 k Ω resistor		90	130	ns	
SR	Slew rate	C _L = 180 pF; R _{pu} = 5 kΩ		60		V/µs	
t _{sd}	Shutdown to high / low-side driver propagation delay	$\label{eq:Vout} \begin{array}{l} V_{OUT} = 0, V_{boot} = V_{CC}, \\ V_{IN} = 0 \text{ to } 3.3 \; V \end{array}$	50	125	200		
tisd	Comparator triggering to high / low-side driver turn-off propagation delay	Measured applying a voltage step from 0 V to 3.3 V to pin CIN	50	200	250	ns	

Notes:

⁽¹⁾Equivalent values as a result of the resistances of three drivers in parallel.

Condition	Lo	Output			
Condition	SD/OD	LIN	HIN	LVG	HVG
Shutdown enable half-bridge tri-state	L	X ⁽¹⁾	X ⁽¹⁾	L	L
Interlocking half-bridge tri-state	Н	Н	Н	L	L
0 "logic state" half-bridge tri-state	Н	L	L	L	L
1 "logic state" low-side direct driving	Н	Н	L	Н	L
1 "logic state" high-side direct driving	Н	L	Н	L	Н

Table 14: Truth table

Notes:

⁽¹⁾X: don't care.





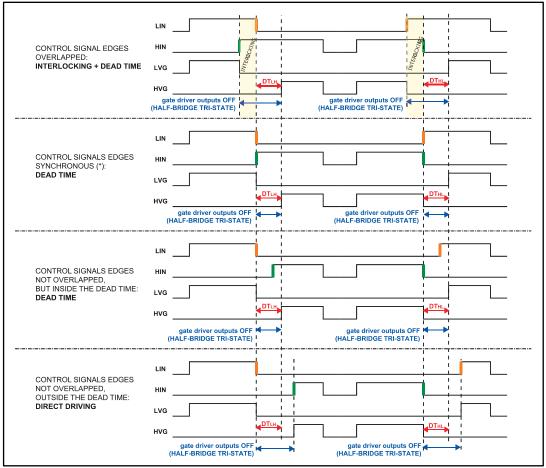


Figure 5: Dead time and interlocking waveform definitions



4 Smart shutdown function

The device integrates a comparator for fault sensing purposes. The comparator has an internal voltage reference V_{REF} connected to the inverting input, while the non-inverting input on pin (CIN) can be connected to an external shunt resistor for simple overcurrent protection.

When the comparator triggers, the device is set to the shutdown state and both of its outputs are set to the low level, causing the half-bridge to enter a tri-state.

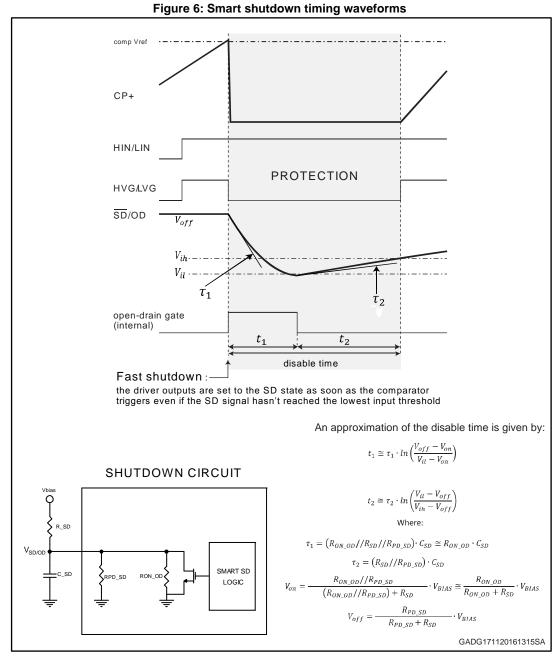
In common overcurrent protection architectures, the comparator output is usually connected to the shutdown input through an RC network so to provide a monostable circuit which implements a protection time following to a fault condition.

Our smart shutdown architecture immediately turns off the output gate driver in case of overcurrent through a preferential path for the fault signal which directly switches off the outputs. The time delay between the fault and output shutdown no longer depends on the RC values of the external network connected to the shutdown pin. At the same time, the DMOS connected to the open-drain output (pin \overline{SD}/OD) is turned on by the internal logic, which holds it on until the shutdown voltage is lower than the minimum value of logic input threshold.

Besides, the smart shutdown function allows the real disable time to be increased while the constant time of the external RC network remains as it is.



Smart shutdown function



Please refer to *Table 13:* "Sense comparator characteristics ($V_{CC} = 15$ V unless otherwise specified)" for internal propagation delay time details.



5 Application circuit example

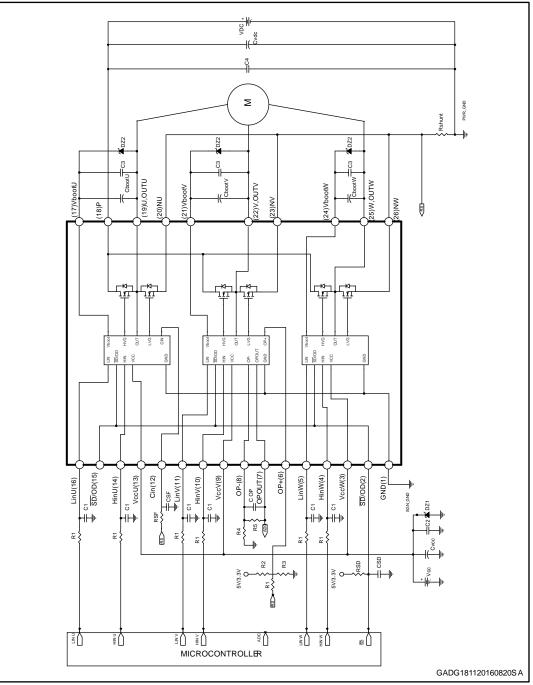


Figure 7: Application circuit example

Application designers are free to use a different scheme according to the specifications of the device.



5.1 Guidelines

- Input signals HIN, LIN are active high logic. A 375 kΩ (typ.) pull-down resistor is builtin for each input. To prevent the input signal oscillation, the wiring of each input should be as short as possible and the use of RC filters (R1, C1) on each input signal is suggested. The filters should be with a time constant of about 100 ns and placed as close as possible to the IPM input pins.
- The use of a bypass capacitor CVCC (aluminum or tantalum) can help to reduce the transient circuit demand on the power supply. Besides, to reduce high frequency switching noise distributed on the power lines, a decoupling capacitor C₂ (100 to 220 nF, with low ESR and low ESL) should be placed as close as possible to V_{cc} pin and in parallel with the bypass capacitor.
- The use of RC filter (RSF, CSF) is recommended to avoid protection circuit malfunction. The time constant (RSF x CSF) should be set to 1 µs and the filter must be placed as close as possible to CIN pin.
- The SD is an input/output pin (open-drain type if it is used as output). The CSD capacitor of the filter on SD should be fixed no higher than 3.3 nF in order to ensure the SD activation time T₁ ≤ 500 ns; the filter should be placed as close as possible to the SD pin.
- The decoupling capacitor C₃ (from 100 to 220 nF, ceramic with low ESR and low ESL), in parallel with each C_{boot}, filters the high frequency disturbance. Both C_{boot} and C₃ (if present) should be placed as close as possible to the U, V, W and V_{boot} pins. Bootstrap negative electrodes should be connected to U, V, W terminals directly and separated from the main output wires.
- To prevent the overvoltage on V_{cc} pin, a Zener diode (Dz1) can be used. Similarly on the V_{boot} pin, a Zener diode (Dz2) can be placed in parallel with each C_{boot}.
- The use of the decoupling capacitor C₄ (100 to 220 nF, with low ESR and low ESL), in parallel with the electrolytic capacitor C_{vdc}, prevents surge destruction. Both capacitors C₄ and C_{vdc} should be placed as close as possible to the IPM (C₄ has priority over C_{vdc}).
- By integrating an application-specific type HVIC inside the module, direct coupling to the MCU terminals without an optocoupler is possible.
- Low inductance shunt resistors should be used for phase leg current sensing.
- In order to avoid malfunctions, the wiring on N pins, the shunt resistor and PWR_GND should be as short as possible.
- The connection of SGN_GND to PWR_GND on one point only (close to the shunt resistor terminal) can help to reduce the impact of power ground fluctuation.

These guidelines are useful for application designs to ensure the specifications of the device. For further details, please refer to the relevant application note.

Symbol	Parameter Test conditions		Min.	Тур.	Max.	Unit
V _{PN}	Supply voltage	Applied among P-Nu, Nv, Nw		300	400	V
Vcc	Control supply voltage	Applied to Vcc-GND	13.5	15	18	V
V _{BS}	High-side bias voltage	Applied to V_{BOOTi} -OUT _i for i = U, V, W	13		18	V
t _{dead}	Blanking time to prevent arm-short	For each input signal	1			μs
fрwм	PWM input signal	-40 °C < T₀ < 100 °C -40 °C < Tј < 125 °C			25	kHz
Tc	Case operation temperature				100	°C

Table 15: Recommended operating conditions

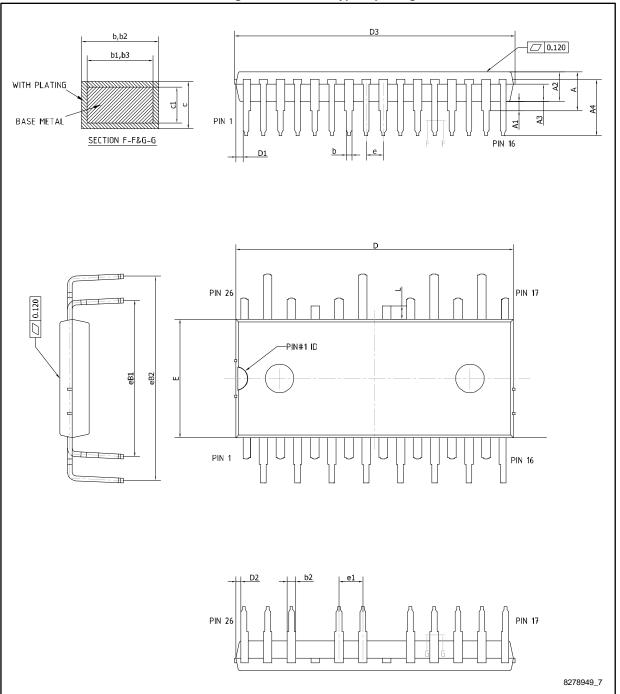


6 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK[®] is an ST trademark.



6.1 NDIP-26L package information







STIPN1M50-H

Package information

90-Н			Package Information		
Table 16: NDIP-26L type C mechanical data					
Dim		mm			
Dim.	Min.	Тур.	Max.		
А			4.40		
A1	0.80	1.00	1.20		
A2	3.00	3.10	3.20		
A3	1.70	1.80	1.90		
A4	5.70	5.90	6.10		
b	0.53		0.72		
b1	0.52	0.60	0.68		
b2	0.83		1.02		
b3	0.82	0.90	0.98		
С	0.46		0.59		
c1	0.45	0.50	0.55		
D	29.05	29.15	29.25		
D1	0.50	0.77	1.00		
D2	0.35	0.53	0.70		
D3			29.55		
E	12.35	12.45	12.55		
е	1.70	1.80	1.90		
e1	2.40	2.50	2.60		
eB1	16.10	16.40	16.70		
eB2	21.18	21.48	21.78		
L	1.24	1.39	1.54		



6.2 NDIP-26L packing information



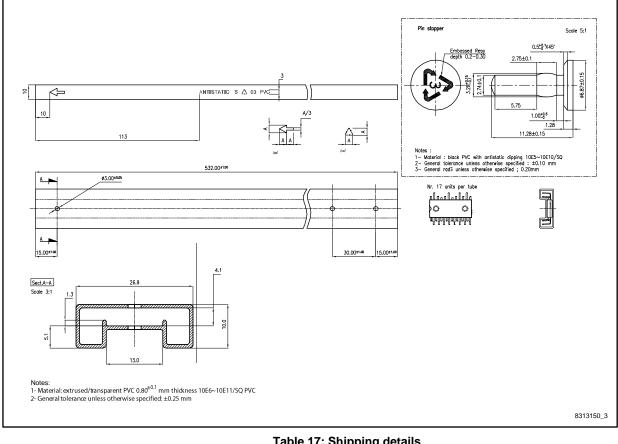


	Table 17: Shipping details			
Parameter	Value			
Base quantity	17 pieces			
Bulk quantity	476 pieces			

20/22



7 Revision history

Table 18: Document revision history

Date	Revision	Changes
18-Nov-2016	1	Initial release.
01-Feb-2017	2	Modified features and description on cover page. Modified <i>Table 15: "Recommended operating conditions"</i>
07-Jun-2017	3	Modified Table 3: "Inverter part", Table 6: "Thermal data" and Table 11: "Logic inputs ($V_{CC} = 15$ V unless otherwise specified)". Minor text changes.



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